

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/531,518	MIYAUCHI, TOSHIAKI	
Examiner		Art Unit		Page 1 of 1
Deborah Yee		1742		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,143,425	11-2000	Tanaka et al.	428/627
*	B	US-4,886,640	12-1989	Garner et al.	420/111
*	C	US-6,228,184	05-2001	Tanaka et al.	148/325
*	D	US-5,013,525	05-1991	Hamada et al.	420/104
*	E	US-4,902,473	02-1990	Arata et al.	420/105
*	F	US-5,998,042	12-1999	Tanaka et al.	428/627
*	G	US-6,409,846	06-2002	Takemura et al.	148/325
*	H	US-6,086,686	07-2000	Tanaka et al.	148/325
*	I	US-6,592,684	07-2003	Yamamura et al.	148/325
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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